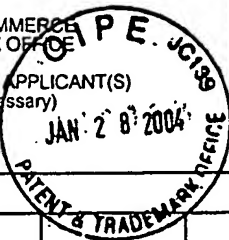


U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)ATTY DOCKET NO.
03500.017349.APPLICATION NO.
10/725,396APPLICANT
KAZUHIRO TAKADAFILING DATE
December 3, 2003GROUP
N.Y.A.

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SKM	5,405,783	04/1995	Pirrung, et al.	436	518	
SKM	5,601,980	02/1997	Gordon, et al.	435	6	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
SKM	05-285000	11/19/93	Japan			Abstract
↓	06-136551	05/17/94	Japan			Abstract
↓	06-192841	07/12/94	Japan			Abstract
↓	2001-050931	02/23/01	Japan			Abstract
↓	2002-065299	03/05/02	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

SKM	M. Schena, et al., "Quantitative Monitoring of Gene Expression Patterns with a Complementary DNA Microarray", Science, vol. 270, pp. 467 to 470 (1995).

EXAMINER /Stephanie Mummert/ (07/27/2006)

DATE CONSIDERED

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1